

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10816734	SRIKRISHNA ET AL.
	Examiner	Art Unit
	Chu, Wutchung	2616

SEARCHED

Class	Subclass	Date	Examiner
370	408	7/18/2007	WC
370	406	7/18/2007	WC
370	392	7/18/2007	WC
370	218	7/18/2007	WC
370	238	7/18/2007	WC
370	401	7/18/2007	WC
370	410	7/18/2007	WC

SEARCH NOTES

Search Notes	Date	Examiner
East search	7/18/2007	WC
Inventorship search	7/18/2007	WC
consulted with SPE Edan Orgad	7/18/2007	WC
Manual search for class 370/406	7/18/2007	WC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner